

Tuning the Electronic Structure of Ag-Pd Alloys to Enhance Performance for Alkaline Oxygen Reduction

Supplementary Information

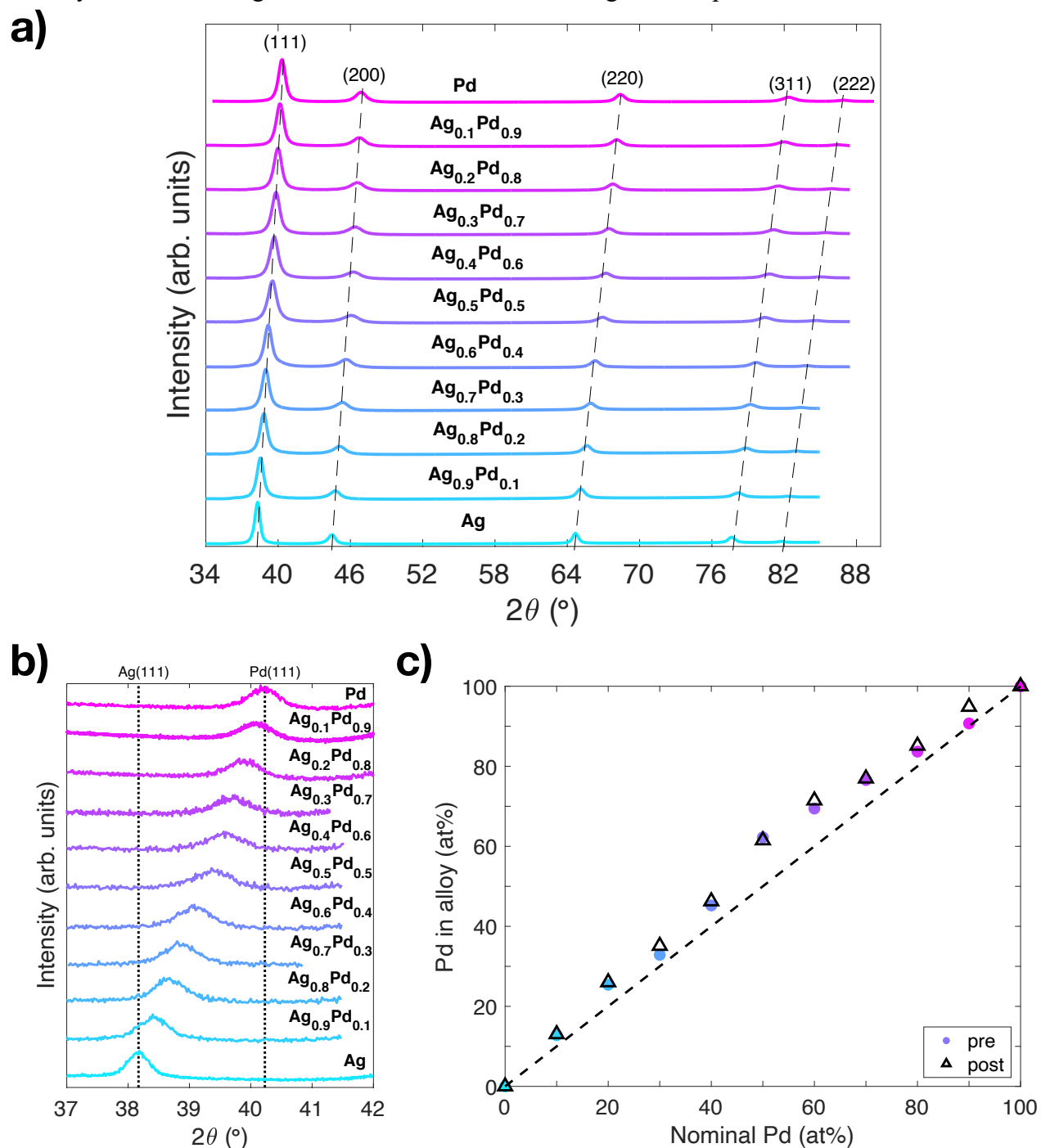
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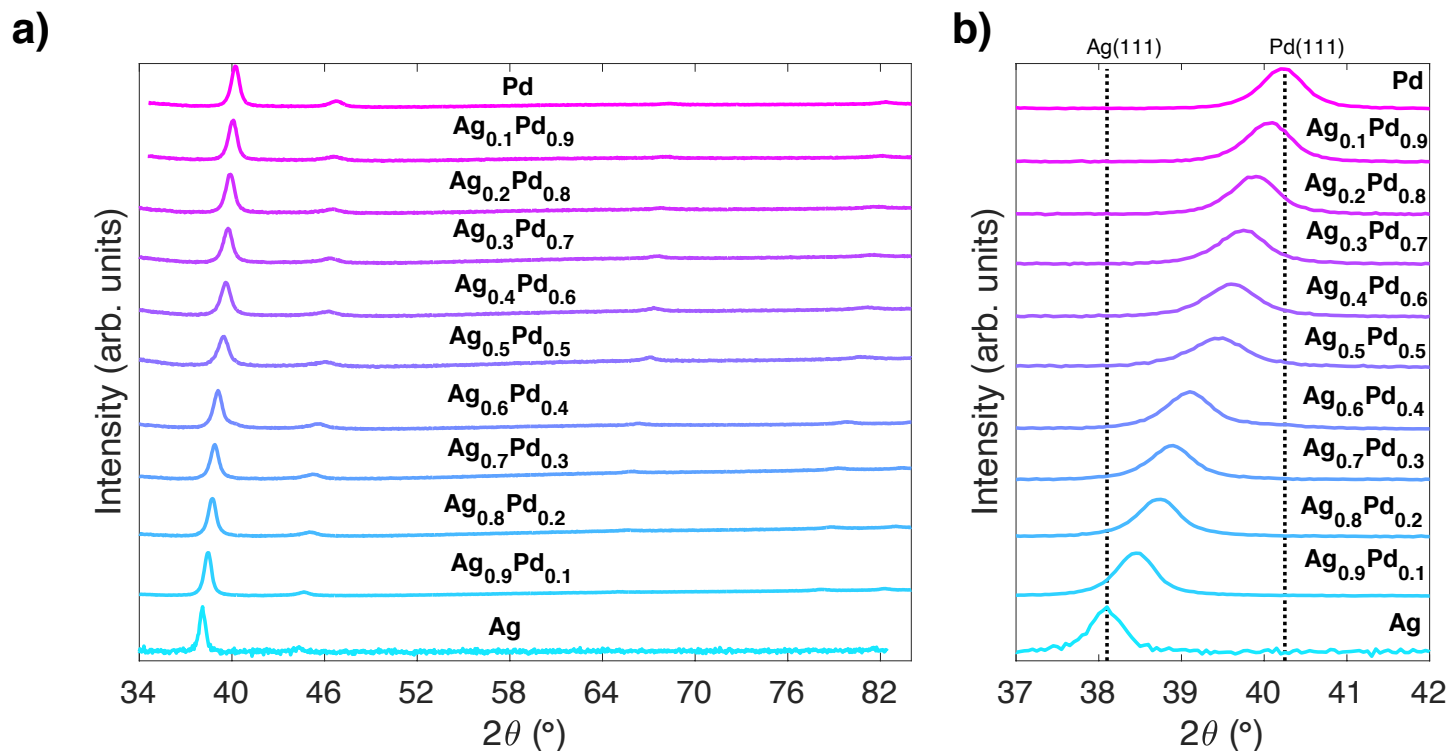
Supplementary Figure 1. GI-XRD of Ag-Pd thin films. **(a)** Full grazing incidence (GI) x-ray diffractograms of as-prepared Ag, Pd, and mixed $\text{Ag}_{1-x}\text{Pd}_{1-x}$ thin films (deposited on standard microscope glass slides). Full 2θ range for data shown in **Figure 1a**. **(b)** GI x-ray diffractograms of the (111) peak for Ag, Pd, and Ag-Pd thin films of different composition after ORR testing, with Ag (38.17°) and Pd (40.23°) peak locations shown by dotted lines, and **(c)** Vegard's Law analysis of the (111) peak showing Pd content in alloy versus nominal Pd composition both pre- and post- electrochemical ORR activity measurements. All post-electrochemistry characterization was done with thin films deposited on glassy carbon substrates.

Grazing incidence XRD measurements on the thin films after electrochemical testing (**Supplementary Figure 1b**), along with the corresponding Vegard's Law analysis (**Supplementary Figure 1c**), indicates that the structure and alloy composition of the thin films did not change significantly after electrochemical experiments. The minor differences in alloy composition given by Vegard's Law before and after electrochemistry are likely due to the low signal to noise ratio in the post-ORR testing diffractograms of the thin films taken on glassy carbon substrates. The absolute value differences in 2θ (111) peak position of the as-deposited versus the after electrocatalysis seen in **Supplementary Table 1** are likely due to the different substrates used, as well as the different grazing incidence angle needed to obtain a measurable signal when using glassy carbon substrates.

Supplementary Table 1. 2θ (111) peak position, d_{111} -spacing, and lattice constant of all Ag-Pd thin film compositions based on GI-XRD measurements taken before (blue) and after (green) electrochemical testing. (In reference to **Figure 1a** and **Supplementary Figure 1**).

Nominal Pd (at%)	As-deposited on glass slides			Post electrocatalysis on glassy carbon		
	(111) peak 2θ position (°)	d_{111} (Å)	a (Å)	(111) peak 2θ position (°)	d_{111} (Å)	a (Å)
0	38.30	2.35	4.07	38.17	2.36	4.08
10	38.55	2.33	4.04	38.42	2.34	4.06
20	38.80	2.32	4.02	38.68	2.33	4.03
30	38.95	2.31	4.00	38.87	2.32	4.01
40	39.20	2.30	3.98	39.09	2.30	3.99
50	39.55	2.28	3.94	39.41	2.29	3.96
60	39.70	2.27	3.93	39.62	2.27	3.94
70	39.85	2.26	3.92	39.73	2.27	3.93
80	40.00	2.25	3.90	39.91	2.26	3.91
90	40.15	2.24	3.89	40.12	2.25	3.89
100	40.35	2.23	3.87	40.23	2.24	3.88

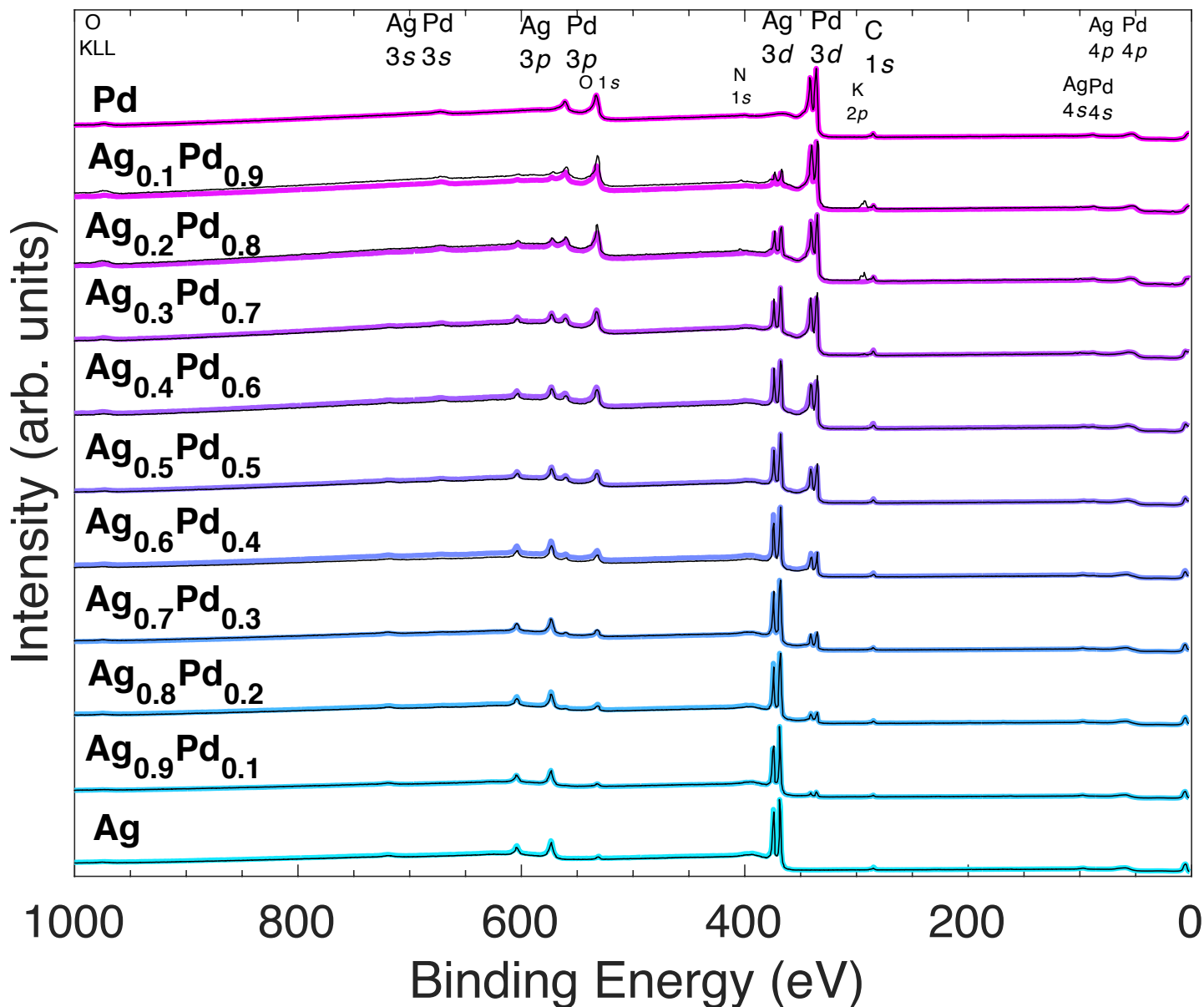
Supplementary Note 2: Symmetric XRD Scans for All Ag-Pd Compositions As-Deposited



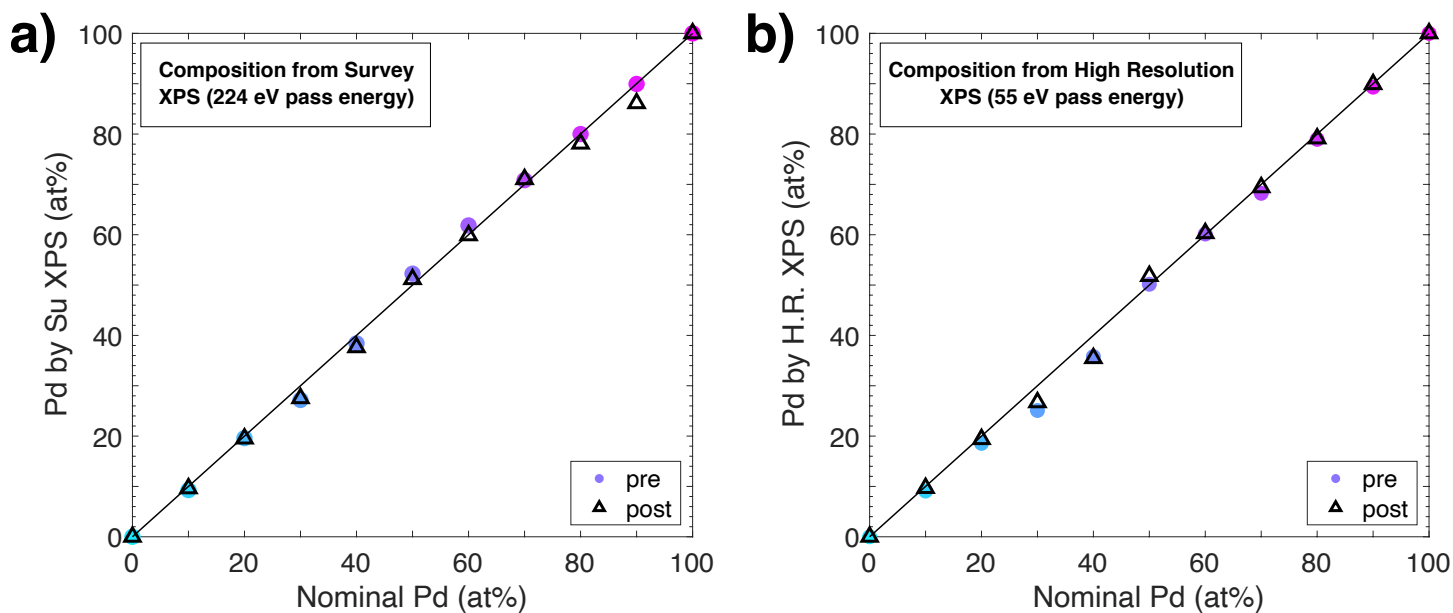
Supplementary Figure 2. Symmetric XRD of Ag-Pd thin films. (a) Full-scan symmetric x-ray diffractograms and (b) magnified symmetric x-ray diffractograms at the (111) peak with Ag (38.1°) and Pd (40.25°) peak locations shown by dotted lines for Ag, Pd, and Ag-Pd thin films of different composition deposited on standard microscope glass slides. (Relevant for **Figure 1a** in main text).

Similarly to in GI-XRD, a strong (111) peak is also present in all diffractograms taken in a symmetric scan ($\omega =$ half of 2θ range) geometry (**Supplementary Figure 2**), consistent with a preferential $\langle 111 \rangle$ out of plane orientation.^{1,2} Specifically, the intensity ratio of the (200) to (111) peak is about $\sim 0.25 - 0.3$, whereas in the reference computed XRD patterns^{3,4} this ratio is $\sim 0.44-0.48$. This preferential orientation has been noted previously and attributed to the thermodynamically favorability of fcc metals to grow with their $\{111\}$ facet exposed.^{1,2}

Supplementary Note 3: Survey XPS Spectra and Compositional Quantification for All Ag-Pd Thin Films Representative of Pre- and Post- Electrochemically Tested Samples



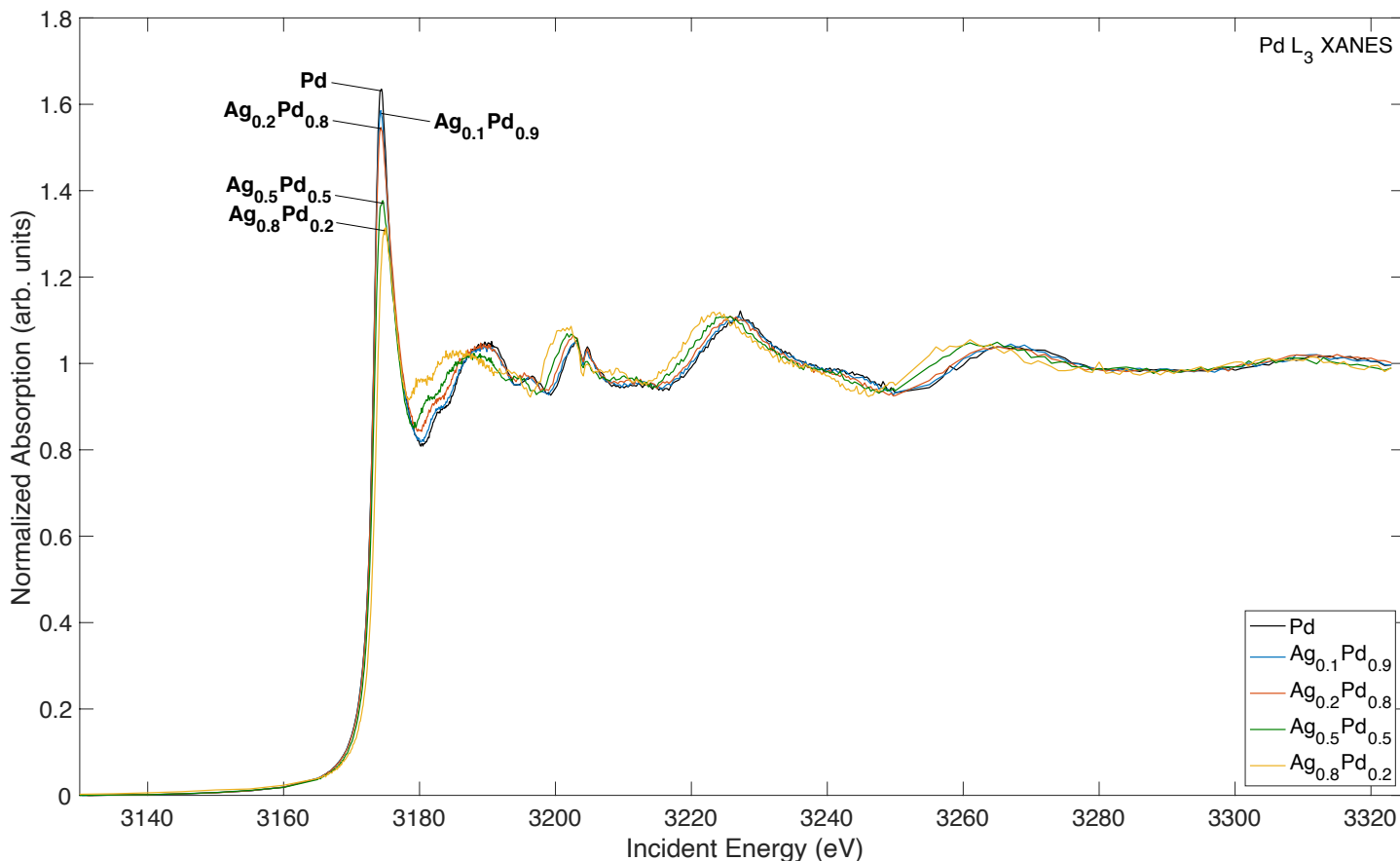
Supplementary Figure 3. Full-scan survey (Su) XPS spectra for Ag, Pd, and Ag-Pd thin films of different composition representative of samples pre- (“cool” color map) and post- (black) electrochemical ORR testing. The pre- and post-ORR Su spectra look nearly identical with the only notable differences being slightly different background intensities and small K 2*p* and N 1*s* peaks specifically for the post-ORR 80 and 90 at% Pd content samples. Any potassium signal likely comes from trace/residual potassium on the sample surface due to being submerged in 0.1 M KOH or from trace potassium accumulated due to storage and transport in air. Any nitrogen signal likely comes from minor contamination due to air storage and transport and/or trace N₂ inside the XPS chamber. The C 1*s* peak is set to 284.8 eV for all spectra. Peaks are labeled at the top. At ~530 eV there is a small O 1*s* peak for Ag; and for the other spectra it overlaps with the Pd 3*p*_{3/2} peak. (Relevant for **Figures 1b** and **1c** in main text).



Supplementary Figure 4. Near-surface composition determined by XPS pre- (circles) and post- (triangles) electrochemical testing for Ag, Pd, and Ag-Pd thin films of different composition determined from (a) survey and (b) high resolution XPS spectra.

A compositional analysis from XPS measurements (**Figures 1c, 1d, and Supplementary Figure 3**) taken before and after electrochemical ORR testing indicates that the thin films exhibited surface compositions consistent with nominal bulk values both pre- and post- electrochemical ORR testing (**Supplementary Figure 4**). This suggests, that within instrument sensitivity, the near-surface composition of the thin films was stable during ORR activity measurements.

Supplementary Note 4: Full XANES Pd L₃-edge Scan

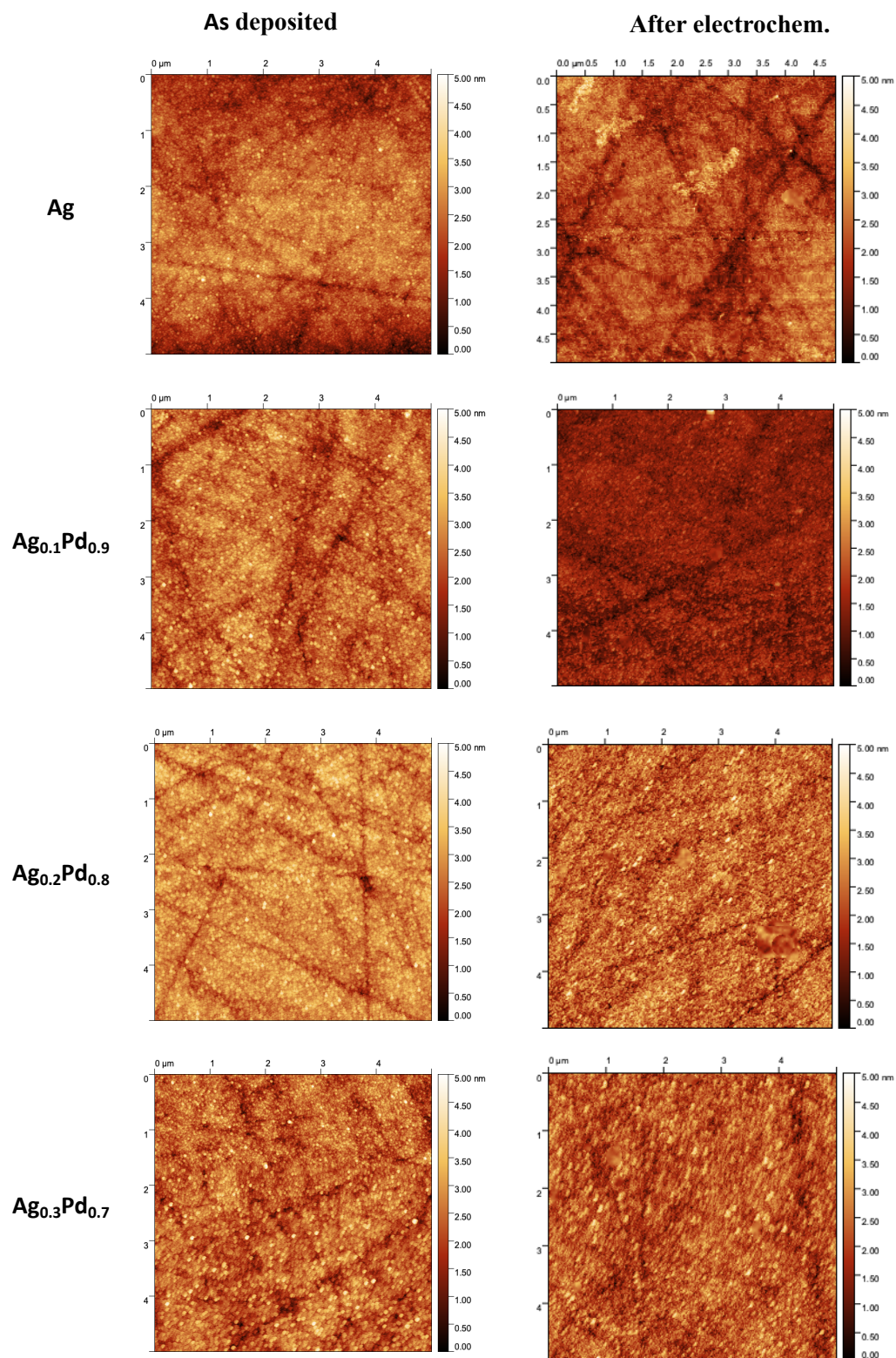


Supplementary Figure 5. Full-scan Pd L₃ x-ray absorption near edge spectra for Pd, Ag_{0.1}Pd_{0.9}, Ag_{0.2}Pd_{0.8}, Ag_{0.5}Pd_{0.5}, Ag_{0.8}Pd_{0.2}. All samples measured on glassy carbon substrates. Full energy-range XAS spectra for data shown in **Figure 1e**.

The filling in the Pd 4*d*-band results in an increase in the incident energy needed to excite Pd electrons from the 2*p* to 4*d* band, which is illustrated by the positive energy shifts (ranging between 0.5 – 1 eV) in the white-line position with increased Ag content.^{5,6}

As explained in the main manuscript, our Pd L₃ XANES agrees well with literature, and therefore we hypothesize that the valence band and unoccupied *d*-states of our Ag-Pd alloys should follow the trends previously observed in literature for related systems.⁷

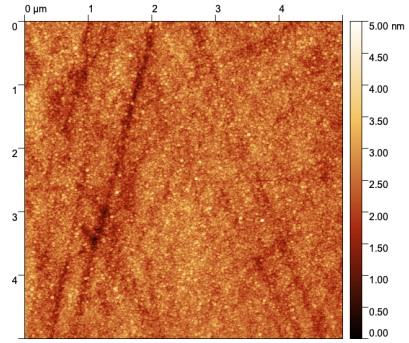
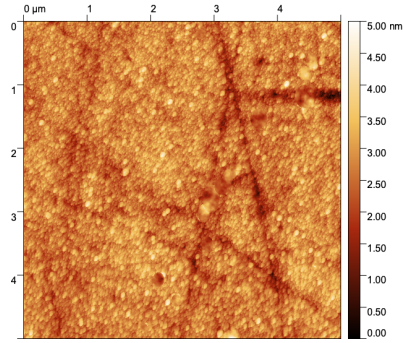
Supplementary Note 5: AFM Imaging for All Ag-Pd Compositions



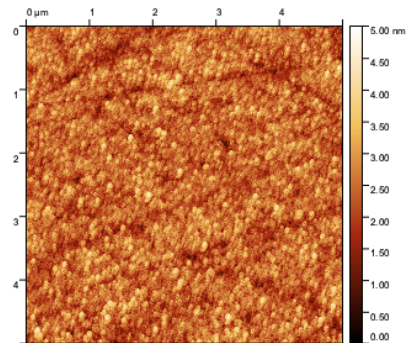
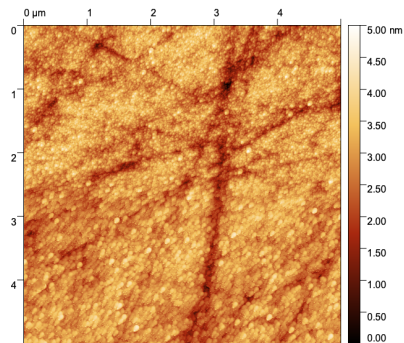
As deposited

After electrochem.

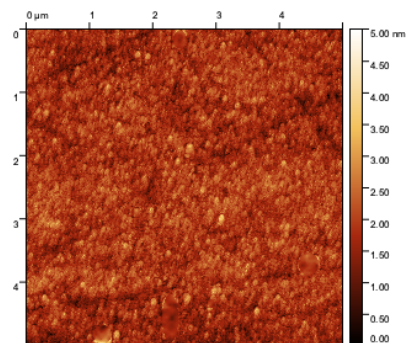
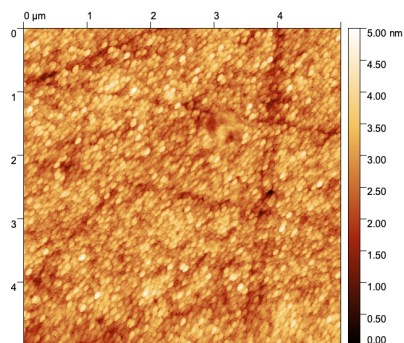
Ag_{0.4}Pd_{0.6}



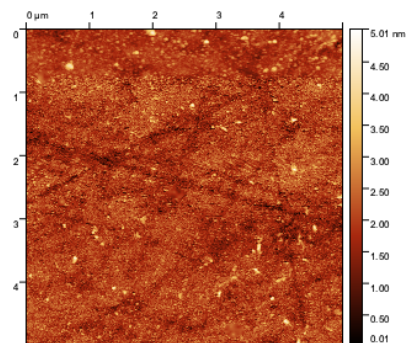
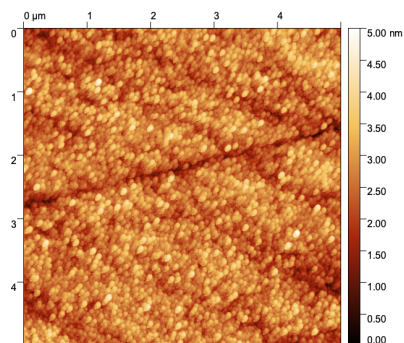
Ag_{0.5}Pd_{0.5}

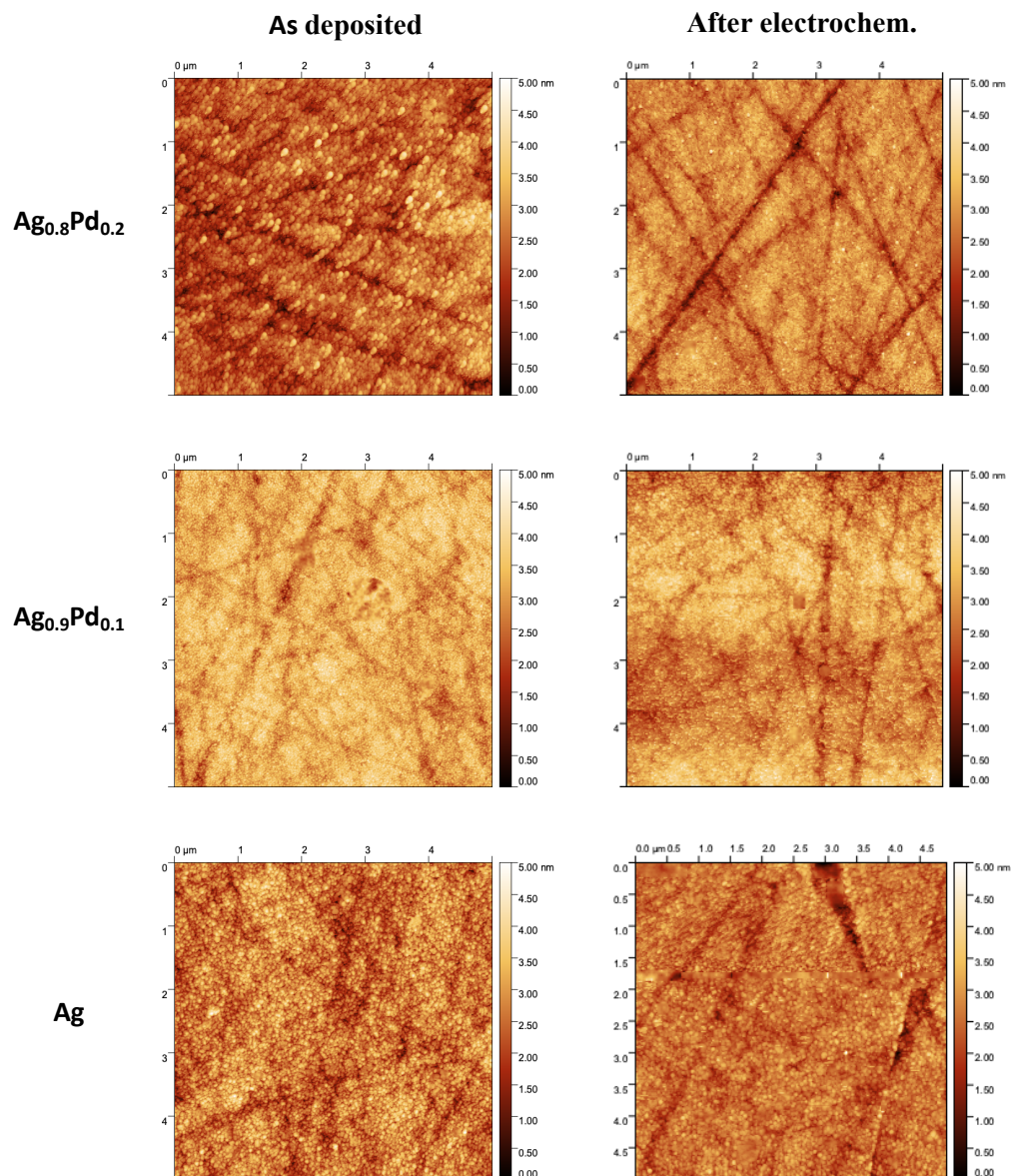


Ag_{0.6}Pd_{0.4}



Ag_{0.7}Pd_{0.3}





Supplementary Figure 6. AFM topography images before and after ORR activity testing for Ag, Pd, and Ag-Pd thin films of different composition deposited on glassy carbon substrates. “After electrochem.” means: after 3 ORR CVs followed by 2 N_2 CVs at 20 mV s^{-1} from $1 - 0 \text{ V vs. RHE}$. Linear color scale from 0 nm to 5 nm (z [height]). (Relevant for **Figure 2** in main text).

Flatness/smoothness in AFM topographical images is represented by color homogeneity, not the actual color being displayed. For example, for $\text{Ag}_{0.7}\text{Pd}_{0.3}$, the “post” image is more dark-red in color compared to the “as

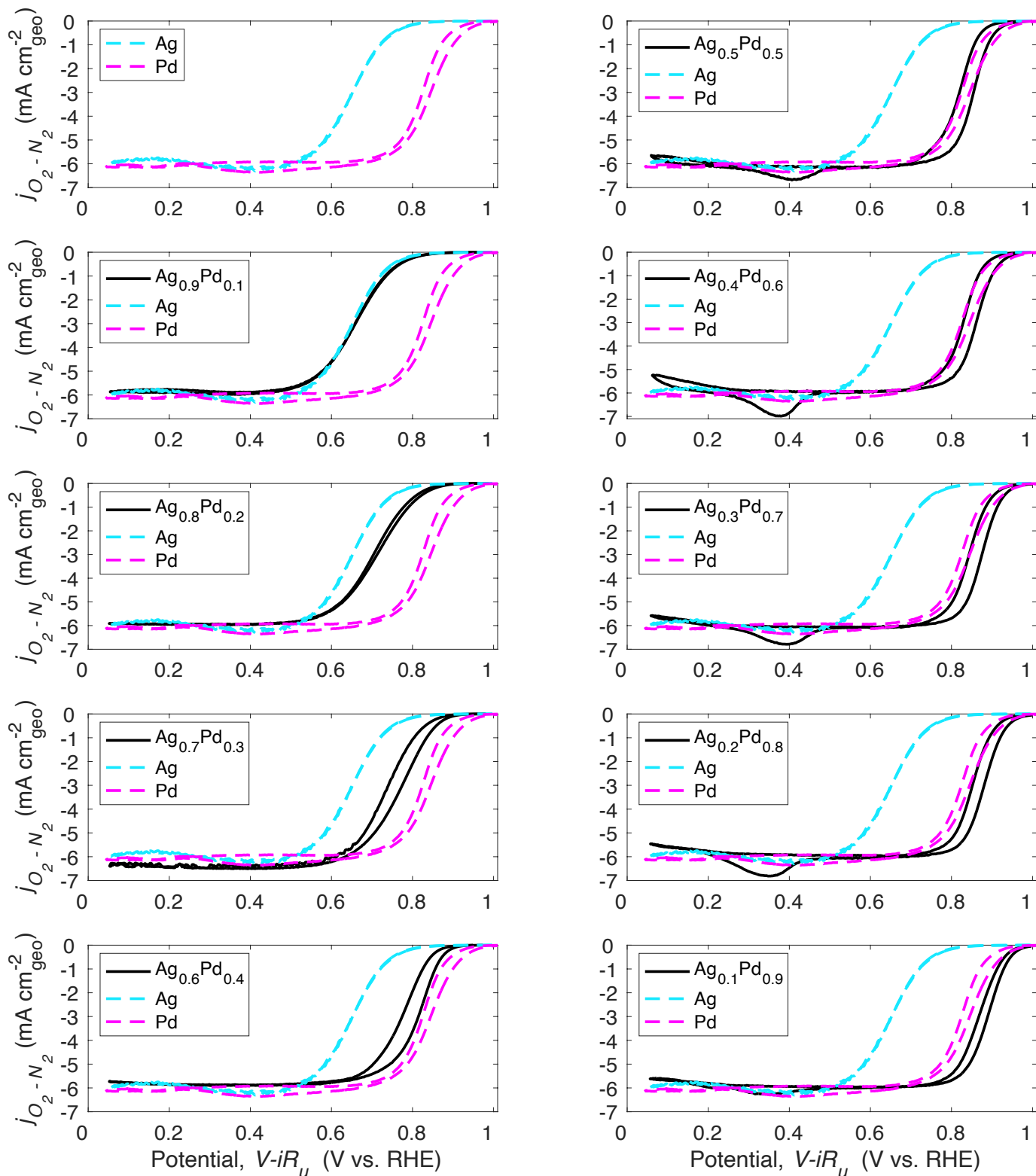
deposited” image, but both images are highly homogeneous in their own color distribution, meaning that they are both highly smooth/flat. The difference in the main/most noticeable color among images can be due to differences in the magnitude of the interactions between the cantilever and the sample surface, as well as the scanning settings, which change sample to sample.

AFM was used to determine the surface roughness and topography of the thin films before and after electrochemical testing. AFM imaging shows a lack of topographical features on the thin films both before and after electrochemical measurements (**Supplementary Figure 6**). The surface roughness factors (RF) of the thin films were estimated by AFM imaging (**Supplementary Table 2**), and they suggest the thin films are very flat and remain flat after electrochemical experiments with RFs ≤ 1.02 .

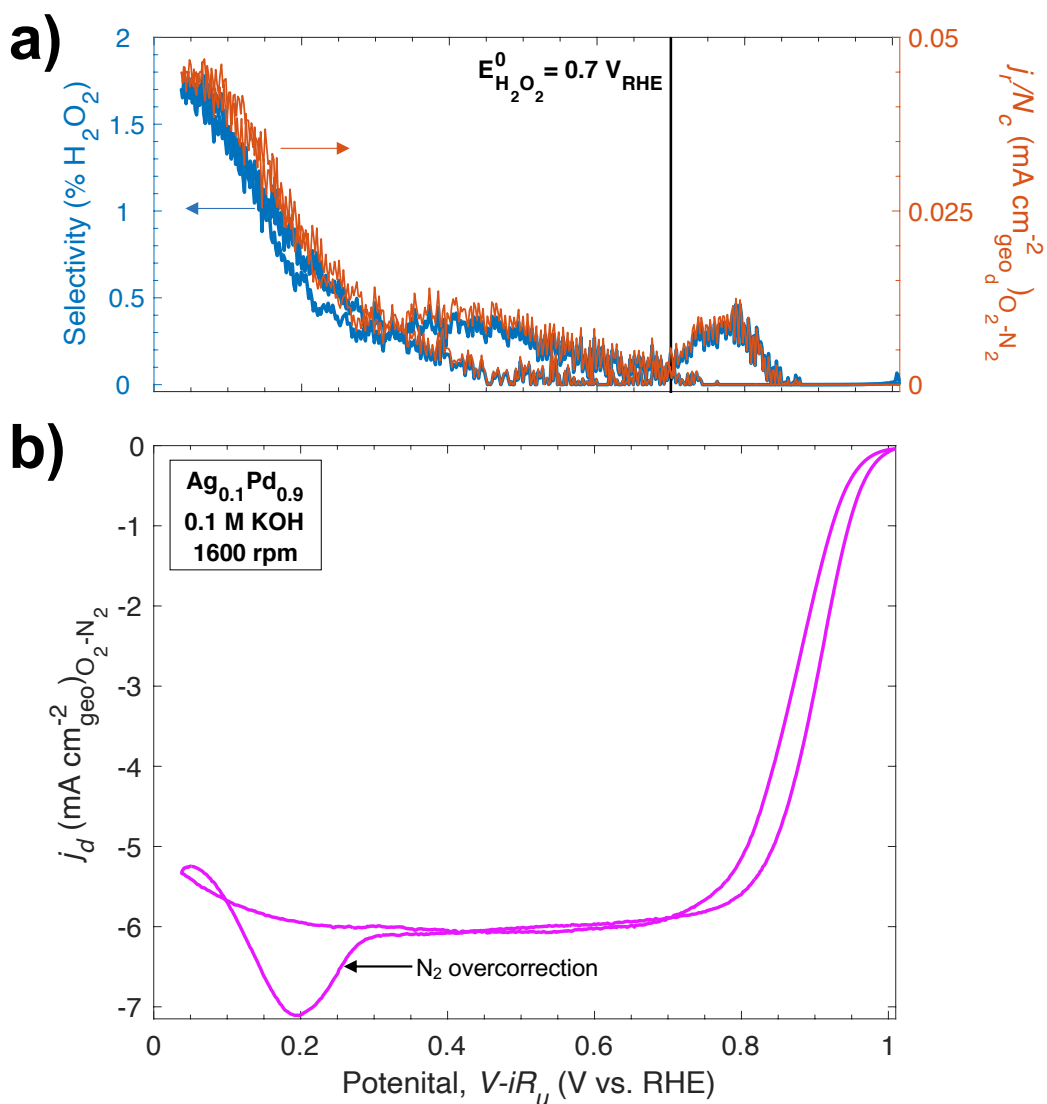
Supplementary Table 2. Roughness factor (RF) and root mean squared (RMS) roughness calculated by AFM for all thin film compositions studied both as deposited and after electrochemical testing.

sample		as deposited		post electrochemical testing	
nominal Pd%	nominal Ag%	RF	RMS roughness (nm)	RF	RMS roughness (nm)
100	0	1.014	3.625	1.005	2.084
90	10	1.013	2.600	1.023	3.609
80	20	1.010	2.356	1.017	3.755
70	30	1.011	2.195	1.009	2.360
60	40	1.009	2.158	1.023	2.378
50	50	1.008	2.339	1.009	2.411
40	60	1.005	1.779	1.009	2.429
30	70	1.005	2.231	1.019	2.957
20	80	1.007	2.377	1.007	2.598
10	90	1.017	2.386	1.009	3.010
0	100	1.018	2.874	1.012	5.946

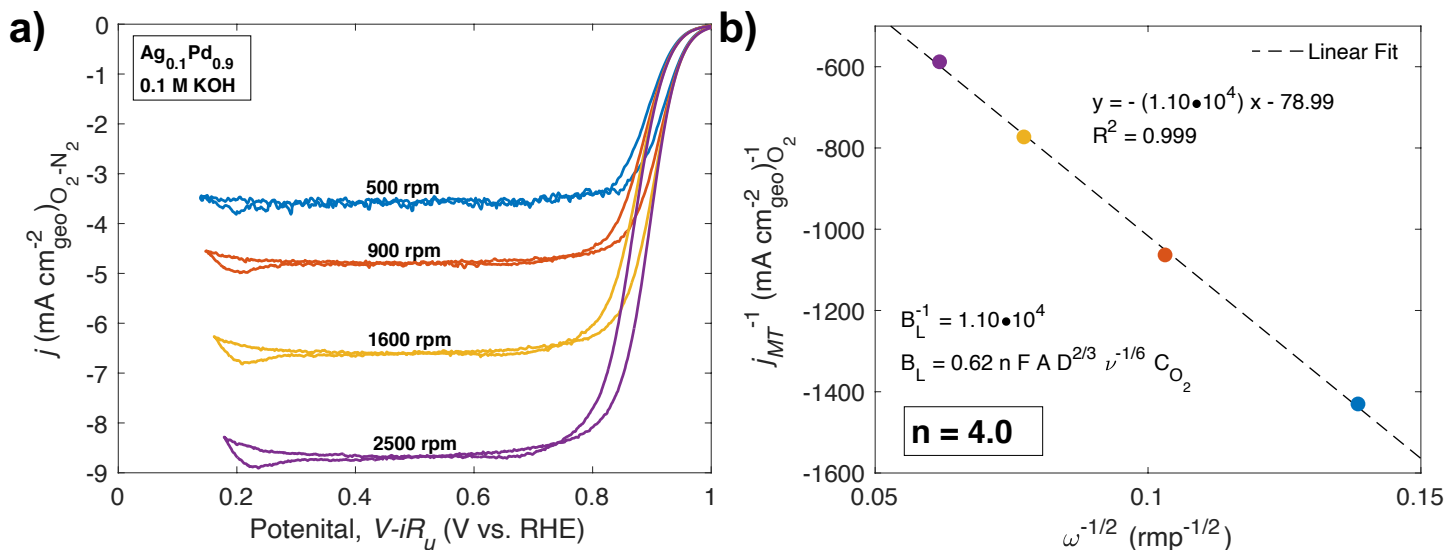
Supplementary Note 6: Electrochemical ORR Activity Evaluation at All Ag-Pd Compositions



Supplementary Figure 7. Representative 3rd cycle CV curves in O₂-saturated 0.1 M KOH for Ag, Pd, and Ag-Pd thin films of different composition at 1600 rpm and at 20 mV s⁻¹. (Relevant for **Figure 2** in main text). The feature present around 0.2 – 0.4 V vs. RHE for the ≥ 50 at% Pd samples is due to an overcorrection in the HUPD region with the subtraction of the N₂ CV profile, suggesting that HUPD is suppressed during the ORR.



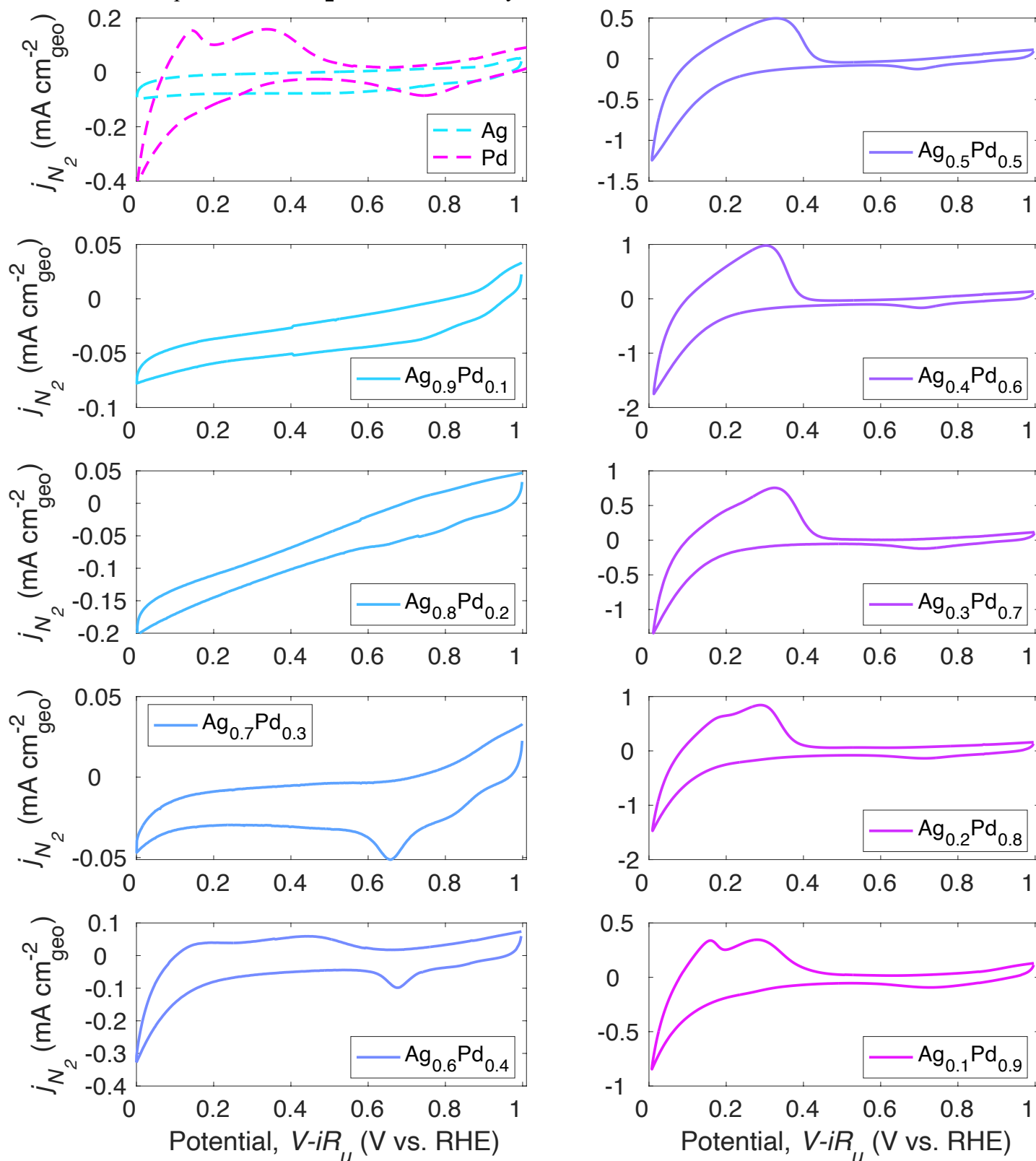
Supplementary Figure 8. Rotating ring disk electrode (RRDE) measurements for Ag_{0.1}Pd_{0.9}. **(a)** H₂O₂ selectivity (left, blue) and equivalent baseline corrected H₂O₂ ring current density (right, orange; based on disk area and a 0.20 collection efficiency, N_c), and **(b)** the ORR disk geometric current density as a function of potential. The Pt ring was set at 1.2 V vs. RHE. The ring collection efficiency was determined by calibration against the ferrocyanide/ferricyanide (0.004 M ferricyanide in 0.1 M KOH) redox couple as done by Zhou, et al⁸. A feature in the disk current density arising from an N₂ CV profile overcorrection of HUPD features is preset at around 0.2 V vs. RHE.



Supplementary Figure 9. Koutecký–Levich analysis. **(a)** ORR CVs as a function of RDE rotation rate, and **(b)** corresponding Koutecký–Levich (KL) selectivity analysis (inverse mass transport (MT) limited current density as a function of the inverse square root of rotation rate) for $\text{Ag}_{0.1}\text{Pd}_{0.9}$. For this experiment the glassy carbon substrate/disk was slightly taller than the change disk insert cavity, causing the edges of the disk, which had catalyst material on it, to be exposed, and hence slightly increasing the overall catalyst surface area relative to the geometric electrode area (0.196 cm^2) leading to mass transport limited current densities slightly more negative than expected given $4e^-$ selectivity. We used $F = 96485.333 \text{ C mol}^{-1}$, $A = 0.196 \text{ cm}^2$, $D = 1.93 \times 10^{-5} \text{ cm}^2 \text{ s}^{-1}$, $\nu = 1.09 \times 10^{-2} \text{ cm}^2 \text{ s}^{-1}$, and $C_{\text{O}_2} = 1.26 \times 10^{-6} \text{ mol cm}^{-3}$.⁹

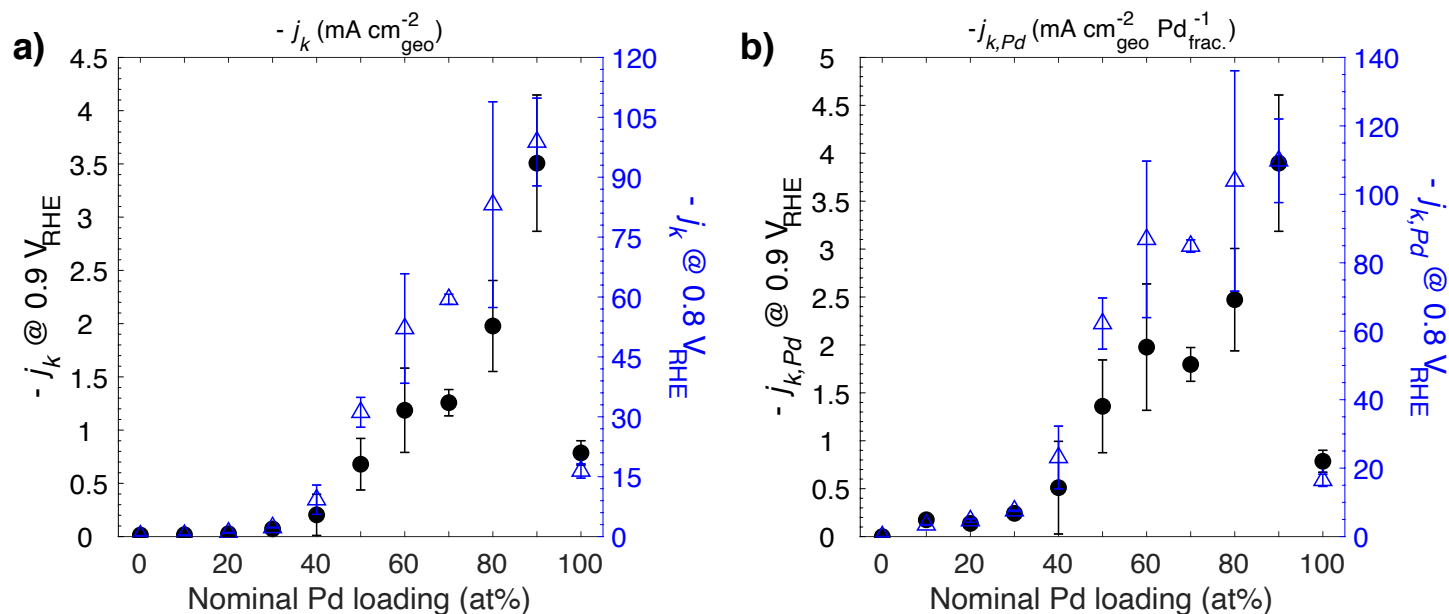
In addition to suggesting full $4e^-$ selectivity, the KL measurements in **Supplementary Figure 9** have overlapping kinetically controlled regions, indicating that mass transport limitations were not problematic.

Characteristic CV profiles under N₂-saturated electrolyte



Supplementary Figure 10. Representative 2nd cycle CV curves in N₂-saturated 0.1 M KOH for Ag, Pd, and Ag-Pd thin films of different composition at 1600 rpm and at 20 mV s⁻¹. (Relevant for **Figure 2** in main text).

The CV profiles in N₂-saturated electrolyte for all Ag_{1-x}Pd_x compositions investigated here are shown in **Supplementary Figure 10**. The CV profile for pure Ag has similar redox features as studied previously on single crystals and polycrystalline electrodes.¹⁰⁻¹³ Redox features around 0.3 to 0.5 V vs. RHE arise from the adsorption and desorption of loosely bound hydroxide species. The lack of a major Ag reduction and oxidation features suggests the electrode remained mostly metallic for the entire scan. The CV profile for pure Pd has similar redox features as investigated previously on Pd electrodes.^{14,15} The Pd CV exhibits a convoluted feature for hydrogen intercalation (expected negative of 0.1 V vs. RHE) and surface adsorption in the cathodic scan around 0 to 0.4 V vs. RHE, with corresponding hydrogen oxidation features in the anodic scan.^{14,15} The lack of a major Pd oxidation feature in the anodic scan suggests that an extensive oxide layer is not forming at the surface, and that the surface remains mostly metallic. The small Pd reduction peak (compared to previous work¹⁴⁻¹⁸) around 0.75 V vs. RHE further supports this hypothesis. The CV profiles for the Ag_{1-x}Pd_x thin films have a combination of the Ag and Pd features. The Pd reduction feature becomes noticeable at ≥ 30 at% Pd loading and shifts to slightly higher potentials with increasing Pd content (approximately from 0.65 to 0.75 V vs. RHE). The reversible Pd hydrogen intercalation and surface adsorption features become noticeable at a ≥ 40 at% Pd loading and are most intense for Ag_{0.4}Pd_{0.6}. The changes in the magnitude of the reversible hydrogen surface adsorption redox features among the profiles of the bimetallic samples with ≥ 50 at% Pd suggest that these processes become easier when the Pd lattice is expanded due to the addition of Ag.



Supplementary Figure 11. Geometric kinetic current density for Ag-Pd thin films. (a) Kinetic current density at 0.9 V (left, black circles) and 0.8 V (right, blue triangles) vs. RHE, and (b) kinetic current density normalized by Pd loading at 0.9 V (left, black circles) and 0.8 V (right, blue triangles) vs. RHE. All data points are representative of the average value from the cathodic and anodic scan of the third CV cycle and error bars are the standard deviation from measurements with separate samples ($n = 2$ samples for 0–30 at% Pd, and $n = 3$ for 40–100 at% Pd). (Relevant for **Figure 2c** in main text).

Due to the large activity range between Ag and Pd, two different metrics were used to compare catalysts: current densities at 0.9 V vs. RHE (**Figure 2c - circles**) for the higher performing systems that are competitive with the state-of-the-art catalysts, and current densities at 0.8 V vs. RHE (**Supplementary Figure 11a**) to meaningfully compare among the Ag-rich catalysts (< 50 % Pd) that have lower onset potentials (< 0.92 V vs. RHE). While error in the extrapolation to kinetic current increases as current increases to values similar to the mass transport limited current, we still use 0.8 V vs. RHE as a reference potential for our best-performing samples to enable a fair constant potential comparison of activity among all the samples investigated in this work (the ORR on the samples with ≤ 30 at% Pd onsets at potentials lower than 0.9 V vs. RHE, making kinetic data at this potential less meaningful for these compositions). Therefore, extracting and comparing kinetic current densities at both 0.9 V and 0.8 V vs. RHE provides the best way to compare kinetic data at relevant potentials across samples and across the literature.

Koutecký–Levich Analysis

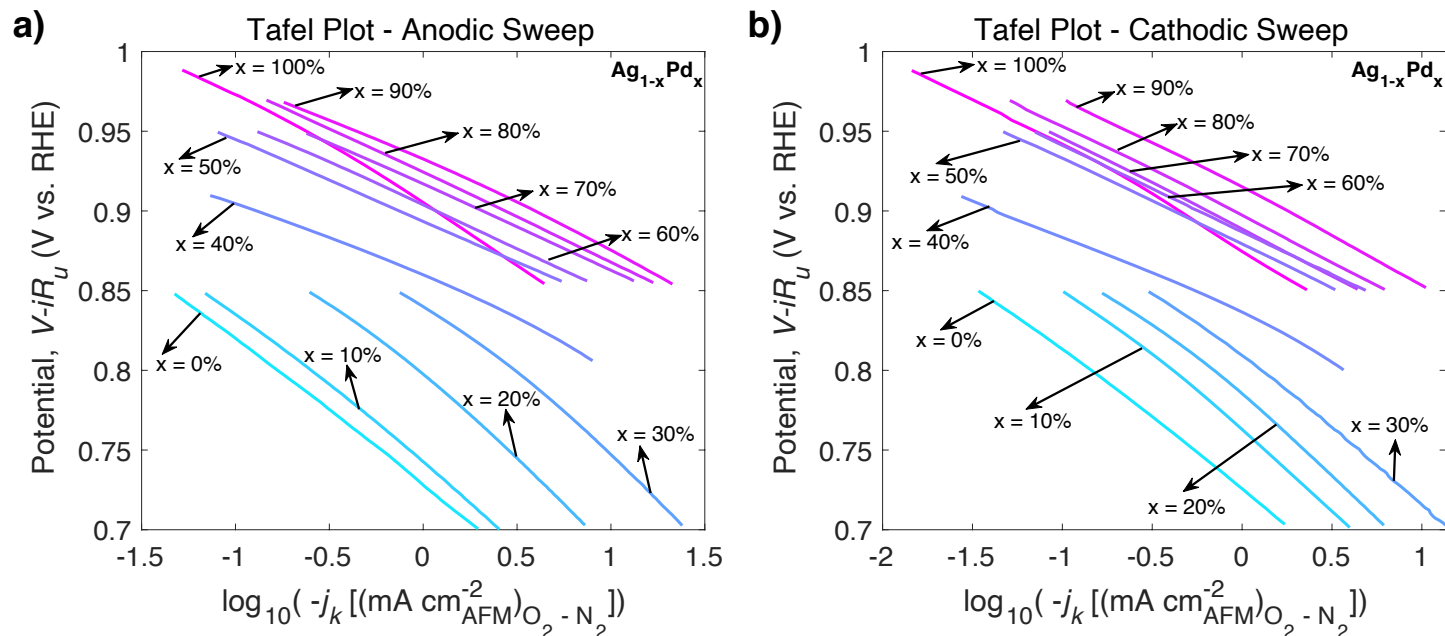
The Koutecký–Levich equation¹⁹ can be expressed as:

$$\frac{1}{i} = \frac{1}{i_k} + \frac{1}{i_{MT}} \quad (\text{Equation 1})$$

where, i is the experimentally measured current, i_k is the kinetic current from the specific electrochemical reaction, and i_{MT} is the experimentally measured mass transport limited current density. i and i_{MT} can be found using cyclic voltammetry, and then used to solve for i_k . Kinetic current density, j_k , can be obtained by normalizing i_k by a representative catalyst surface area, and thus be used as a measure of specific (intrinsic) activity.

Tafel Analysis

A Tafel analysis consists of plotting the base ten logarithm of activity (in our case kinetic current density) versus potential, where the slope(s) of such curve corresponds to the Tafel slope(s). **Supplementary Figure 12** shows a representative Tafel plot analysis using the ORR CV curves in **Supplementary Figure 7**. The Tafel slope is a measure of the number of volts required to increase activity by one order of magnitude. Tafel slopes are reported in **Figure 2b**.



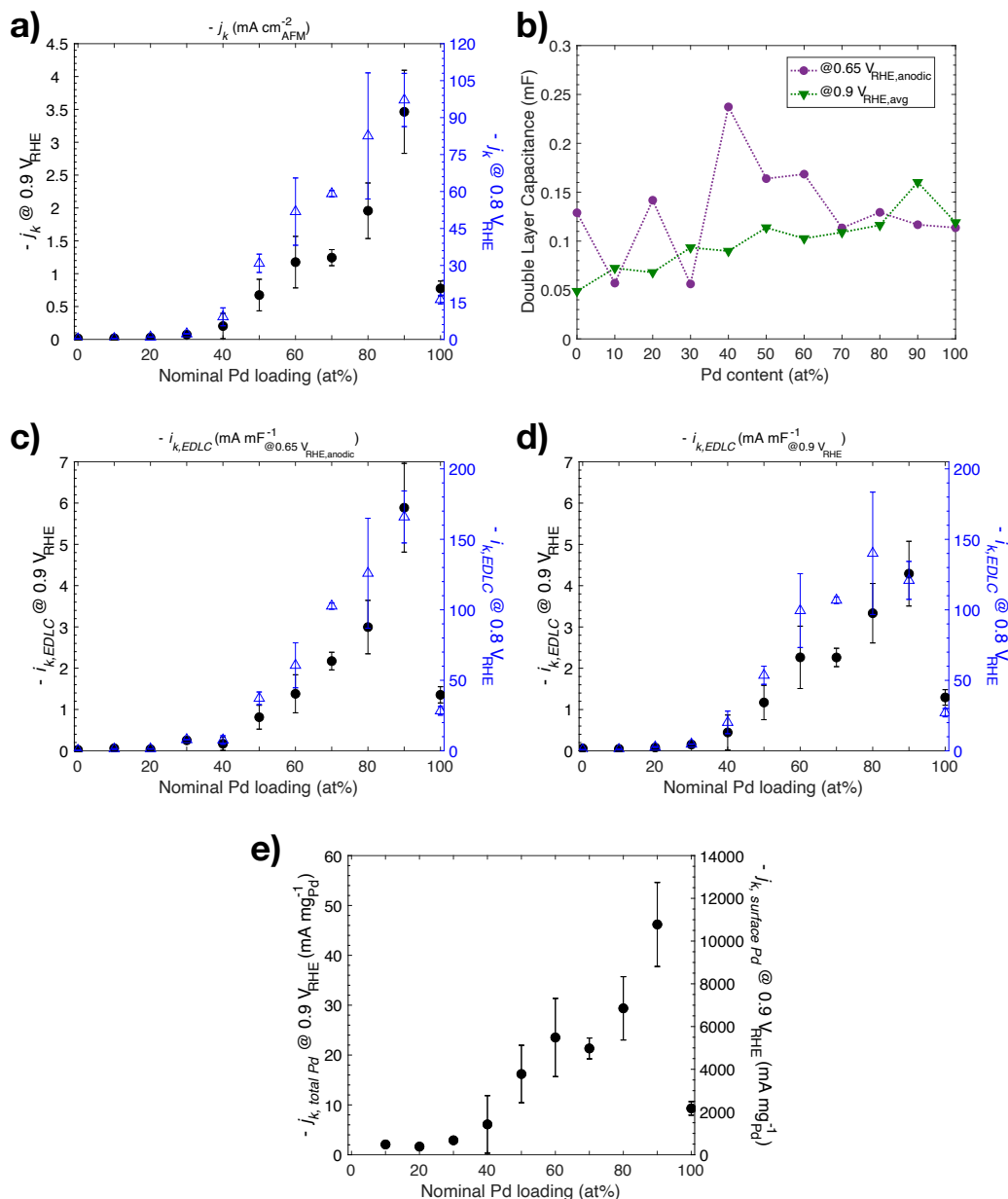
Supplementary Figure 12. Representative Tafel plot analysis (using the ORR CV curves in **Supplementary Figure 7**). (a) Anodic of forward sweep and (b) cathodic or reverse sweep. (Relevant for **Figure 2** in main text).

Performance Summary

Supplementary Table 3. Summary of $\text{Ag}_{1-x}\text{Pd}_x$ ORR activity performance. The kinetic current densities are normalized by the roughness factors determined by AFM (**Supplementary Table 2**), and are representative of specific activity. The Tafel Slopes are for the low current density (lcd) regions. Exchange current densities were calculated by setting potential equal to 1.23 V vs. RHE and using the lcd region Tafel linear fit (Potential = Tafel Slope * $\log_{10}(-j_k)$ + constant). All average (AVG) data points are representative of the average value from the cathodic and anodic scan of the third CV cycle from measurements on separate samples (n = 2 samples for 0–30 at% Pd, and n = 3 for 40–100 at% Pd). Relevant for **Figure 2c** in the main text, and **Supplementary Table 4**.

Sample	Onset Potential ($V_{\text{RHE}}\text{)}_{\text{AVG}}$ @0.1 mA $\text{cm}_{\text{geo}}^{-2}$	- j_k (mA $\text{cm}_{\text{AFM}}^{-2}$) @ 0.9 V vs RHE, AVG	- j_k (mA $\text{cm}_{\text{AFM}}^{-2}$) @ 0.9 V vs RHE, Cathodic	- j_k (mA $\text{cm}_{\text{AFM}}^{-2}$) @ 0.9 V vs RHE, Anodic	- Tafel Slope (mV dec^{-1}) $_{\text{AVG}}$ lcd	- AVG Kin. Exchange current density (mA $\text{cm}_{\text{geo}}^{-2}$)
Pd	0.956	0.775	0.416	1.134	57.9	1.51E-06
$\text{Ag}_{0.1}\text{Pd}_{0.9}$	0.977	3.463	2.024	4.902	51.2	1.10E-06
$\text{Ag}_{0.2}\text{Pd}_{0.8}$	0.965	1.958	0.924	2.991	48.3	3.09E-07
$\text{Ag}_{0.3}\text{Pd}_{0.7}$	0.959	1.244	0.586	1.901	44.5	4.00E-08
$\text{Ag}_{0.4}\text{Pd}_{0.6}$	0.948	1.176	0.480	1.871	41.5	1.10E-08
$\text{Ag}_{0.5}\text{Pd}_{0.5}$	0.935	0.674	0.266	1.083	39.9	5.23E-09
$\text{Ag}_{0.6}\text{Pd}_{0.4}$	0.916	0.203	0.094	0.312	45.7	2.95E-08
$\text{Ag}_{0.7}\text{Pd}_{0.3}$	0.891	0.072	0.047	0.098	89.6	3.91E-05
$\text{Ag}_{0.8}\text{Pd}_{0.2}$	0.871	0.027	0.028	0.027	97.9	3.52E-05
$\text{Ag}_{0.9}\text{Pd}_{0.1}$	0.843	0.017	0.017	0.018	94.4	9.24E-06
Ag	0.825	0.015	0.014	0.016	90.3	3.58E-06

Supplementary Note 7: Kinetic Current Normalizations

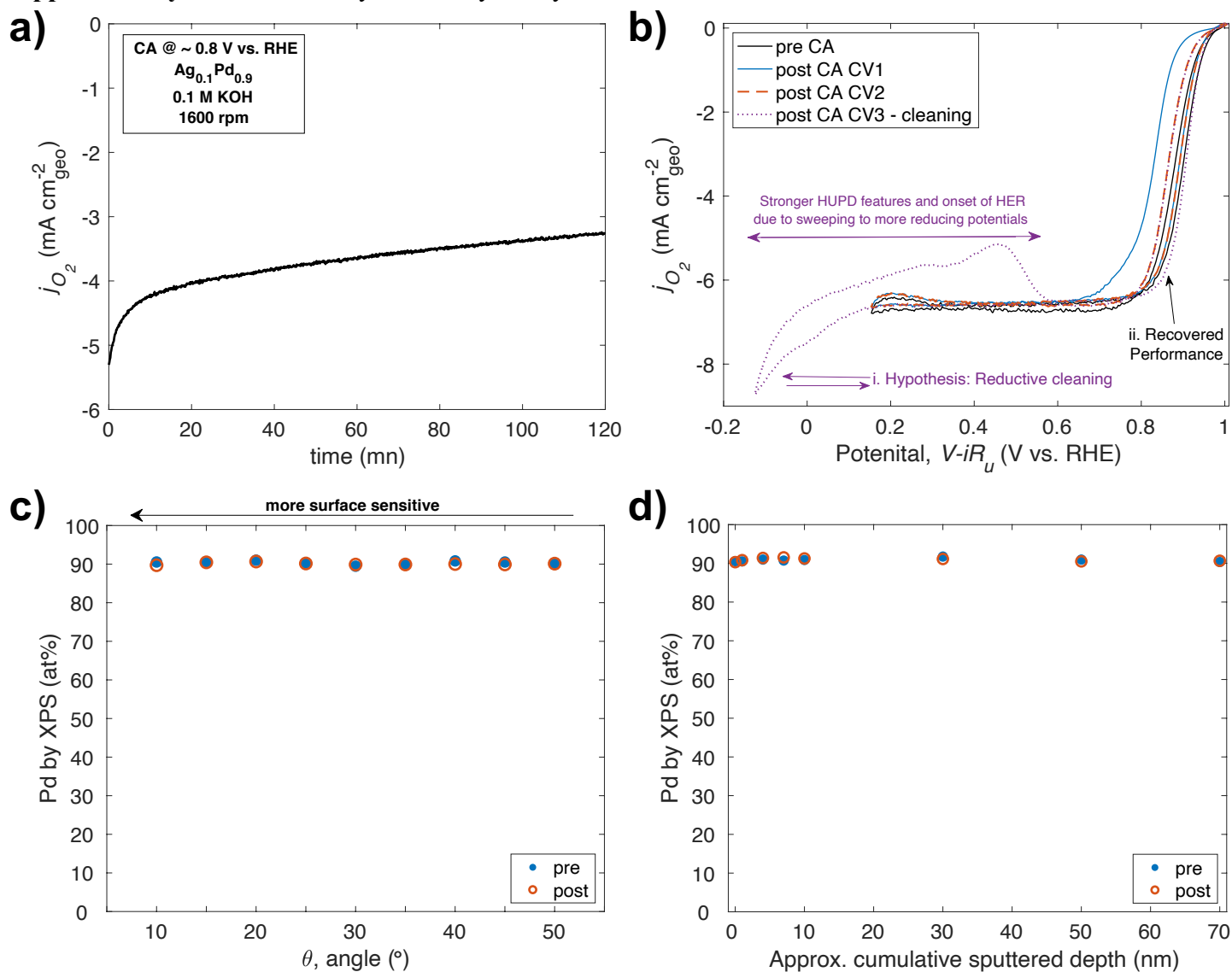


Supplementary Figure 13. Kinetic current normalizations. **(a)** Kinetic current density (**Supplementary Figure 11**) at 0.9 V (left) and 0.8 V (right) vs. RHE (average of cathodic and anodic scans) normalized by the AFM derived roughness factors (as deposited on glassy carbon). **(b)** Electrochemical double layer capacitance (EDLC) calculated at 0.65 V vs. RHE on the anodic CV sweep (black) and at 0.9 V vs. RHE (average of cathodic and anodic sweep) (green) as a function of Pd content. **(c)** Kinetic current at 0.9 V (left) and 0.8 V (right) vs. RHE (average of cathodic and anodic scans) normalized by the EDLC at 0.65 V vs. RHE on the anodic CV sweep, and **(d)** kinetic current at 0.9 V (left) and 0.8 V (right) vs. RHE (average of cathodic and anodic scans) normalized by the average EDLC at 0.9 V vs. RHE. **(e)** Pd-mass activity at 0.9 V vs. RHE relative to the total thin film Pd content (left y-axis) and relative to the estimated surface Pd coverage (right y-axis). (Relevant for **Figure 2c** in main text). All data points are representative of the average value from the cathodic and anodic scan of the third CV cycle and error bars are the standard deviation from measurements with separate samples ($n = 2$ samples for 0–30 at% Pd, and $n = 3$ for 40–100 at% Pd). (Relevant for **Figure 2c** in main text).

All observed trends in activity hold after various forms of normalization (**Supplementary Figure 13**). **Supplementary Figure 13b** shows that the EDLC is fairly constant within the technique limitations for the Ag-Pd system (on the same order of magnitude) for all thin films with different Ag-Pd composition.

Mass activity on **Supplementary Figure 13e** was estimated based on the Pd (density of 11.9 g cm^{-3}) volume content of the thin films with respect to their overall (left y-axis) or monolayer (right y-axis) thicknesses, 70 nm and $\sim 0.3 \text{ nm}$ respectively. Given that all thin films in this work were nominally flat and non-porous on the resolution of AFM, the surface-Pd mass activity (right y-axis, **Supplementary Figure 13e**) is likely a more representative activity metric than the total-Pd mass activity (left y-axis, **Supplementary Figure 13e**).

Supplementary Note 8: Stability/Durability Analysis



Supplementary Figure 14. Stability/durability examination of Ag $_{0.1}$ Pd $_{0.9}$. **(a)** 2 hr chronoamperometry (CA) at ~ 0.8 V vs. RHE, **(b)** pre- and post-CA cyclic voltammetry (CV) tests. **(c)** Pre- (blue, filled) and post- (orange, unfilled) stability measurements (CA + CVs) angle resolved (AR) XPS Pd atomic composition as a function of sample-to-detector angle, θ . Note that $\theta = 45^\circ$ is the standard/default collection angle for non-AR XPS measurements, with an estimated probe depth of 3.1 nm.²⁰ AR-XPS measurements were taken using a standard collection aperture because no peak signal was observed using the narrow collection aperture (slit cover on detector). The estimated probe depth at $\theta = 10^\circ$ is ~ 0.8 nm.²⁰ We estimated probe (95% of electrons probed) depth as $d_{95\%} = 3\lambda\sin\theta$, based on the estimated Ag $_{0.1}$ Pd $_{0.9}$ inelastic mean free path ($\lambda_{Ag_{0.1}Pd_{0.9}}$), and defined $\lambda_{Ag_{0.1}Pd_{0.9}} = 0.1\lambda_{Ag} + 0.9\lambda_{Pd} \approx 1.449$ nm, where $\lambda_{Ag} \approx 1.53$ nm and $\lambda_{Pd} \approx 1.44$ nm at an electron kinetic energy of 1096 eV (approximately equivalent to the binding energies corresponding to the Ag and Pd 3d peaks).²⁰ **(d)** Pd content (at%) as a function of cumulative sputtered depth pre- (blue, filled; separate sample from the same synthesis batch) and post- (orange, unfilled) stability measurements (CA + CVs) determined by XPS depth profiling (Ar $^+$ sputtering, sputtering rate calibrated versus SiO $_2$).

Representative Stability Testing of Ag_{0.1}Pd_{0.9}

For our best performing composition, Ag_{0.1}Pd_{0.9}, we performed chronoamperometry (CA) at ~ 0.8 V vs. RHE for 2 hrs (**Supplementary Figure 14a**) and saw a decrease in current of about 40% (interestingly, it is seen to decrease linearly after around 15 min). We hypothesize that the decrease in performance is due to reversible adventitious carbon uptake due to carbon corrosion from the graphite rod counter electrode, as well as possible Pd and/or Ag partial surface oxidation; the latter is in fact the main source of decreased performance in similarly high performing Pt-based ORR catalysts. ORR CVs pre- and post-CA testing (**Supplementary Figure 14b**) support this hypothesis, as 100% of the initial (pre-CA) performance was recovered by cycling the working electrode up to around -0.2 V vs. RHE to reductively clean off the adventitious carbon and any surface oxide on the film's surface. Additionally, AR-XPS (**Supplementary Figure 14c**) and XPS depth profiling (**Supplementary Figure 14d**) indicate that the composition of the film did not significantly change after stability testing. Altogether, our stability testing indicates that there is no intrinsic material or performance degradation in the timescale of our experiments.

Limited Ag_{1-x}Pd_x Stability Testing

Ag_{1-x}Pd_x thin film mechanical instabilities (not related to intrinsic activity) made our system not conducive for long-term durability testing. When cycling and chronoamperometric experiments were attempted the thin films partially or totally delaminated within three hours of testing. For all samples tested, we collected 3 ORR CVs as activity measurements. The first CV serves as a “cleaning” cycle, and the second and third serve as duplicate activity measurements for each sample tested (2 or 3 samples at each for all samples tested composition). These last 2 CVs were very reproducible for each sample and we report all our results using the third ORR CV cycle for each sample.

To assess the material response to electrochemical testing, we characterized the structural, morphological, and compositional surface changes after electrocatalysis (3 CVs in O₂-saturated 0.1 M KOH, followed by 2 CVs in N₂-saturated electrolyte, followed by 5 CVs at different scan rates in N₂-saturated electrolyte, all at 1600 rpm) via XPS, GI-XRD, and AFM, respectively. Respectively, XPS (**Supplementary Figure 4**), GI-XRD (**Supplementary Figure 1**), and AFM (**Supplementary Figure 6** and **Supplementary Table 2**) suggest that the composition, structure and extent of alloying, and surface smoothness of our thin film Ag_{1-x}Pd_x electrocatalysts remain largely unchanged (within instrument sensitivity) after undergoing ORR activity characterization experiments. This post-characterization suggests that our catalyst surface does not change on the timescale of our electrochemical measurements and indicates that the ex-situ material properties can be meaningfully related to the activity trends.

Supplementary Note 9: Comparison to State-of-the-Art Specific Activity

Supplementary Table 4. Comparison to a selection of high-performing ORR catalysts in 0.1 M KOH (or similar) using a RDE setup. We only report representative catalysts among the most active found in the literature, where kinetic current density is given or easily calculated and explicitly normalized by a physically representative exposed catalyst (or active site) surface area (“*cat*”) (also referred to as electrochemically active surface area (ECSA)). Examples of ECSA techniques are AFM surface roughness for thin films and flat surfaces, electrochemical stripping (e.g. of CO or Cu), hydrogen under-potential deposition, metal-oxide layer reduction, and scan rate potential-cycling.^{21,22} In the absence of AFM, geometric electrode area was taken as an acceptable approximate ECSA only for well-defined single crystal catalysts. Outside of this work, references are for linear sweep voltammetry data. For our Ag-Pd thin films in this table, we report the average (from the cathodic and anodic cycle) specific activity; see **Supplementary Table 3** for the individual activity at each cycle leg (our anodic/forward cycle shows slightly higher activities than the average we report in this table). Nomenclature: (111) = (111) oriented single crystal, @ = on/at/on top, NPs = nanoparticles, NCs = nanocrystals, / = supported on (e.g. Pt/C = Pt supported on carbon).

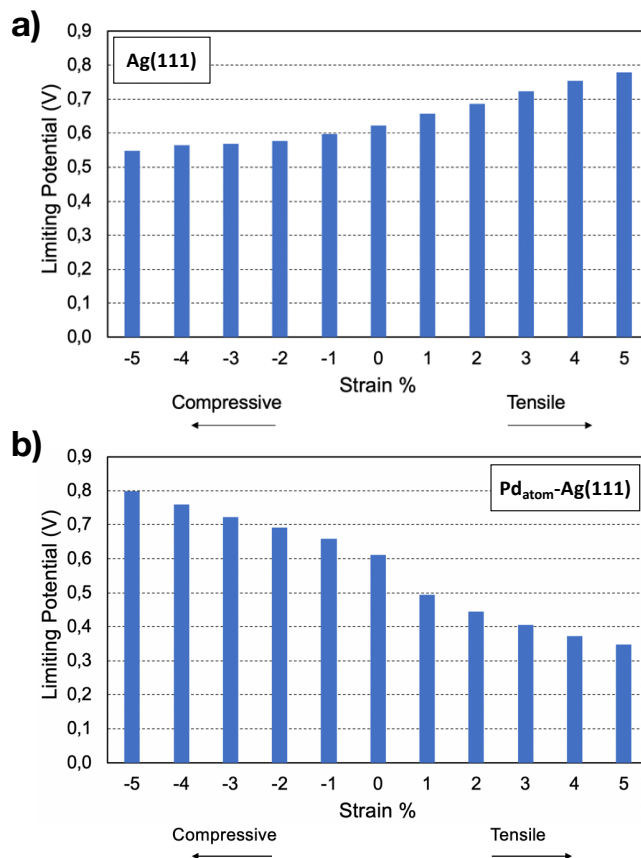
Catalyst	Specific Activity (mA cm _{cat} ⁻²) @0.9 V vs. RHE	Electrolyte	Scan Rate (mV s ⁻¹)	Reference
PdMo bimetallane/C	11.7	0.1 M KOH	20	23
Ag _{0.1} Pd _{0.9}	3.46	0.1 M KOH	20	this work
Pt(111)	3.23	0.1 M KOH	50	24
Pd ₃ Bi	2.3	0.1 M KOH	20	25
PdCu/C	2.30	1 M KOH	5	16
Ag _{0.2} Pd _{0.8}	1.96	0.1 M KOH	20	this work
(activated) PtCu ₃ NPs/C	1.95	0.1 M KOH	5	26
Ag _{0.3} Pd _{0.7}	1.24	0.1 M KOH	20	this work
Ag _{0.4} Pd _{0.6}	1.18	0.1 M KOH	20	this work
Pd/C	0.92	1 M KOH	5	16
Pd	0.77	0.1 M KOH	20	this work
Ag _{0.5} Pd _{0.5}	0.67	0.1 M KOH	20	this work
cubic Pd NPs	0.56	0.1 M KOH	10	27
Pd/C	0.52	0.1 M KOH	20	25
Pt ₃ Cu NPs/C	0.50	0.1 M KOH	5	26
Pd metallane/C	0.48	0.1 M KOH	20	23
Pd/W ₁₈ O ₄₉	0.45	0.1 M KOH	10	28
Bulk Pd	0.42	0.1 M KOH	10	27
PdPt Alloy NCs	0.40	0.1 M KOH	10	29
Pd/C-600	0.39	0.1 M NaOH	10	30

PtCu NPs/C	0.33	0.1 M KOH	5	26
Pt NPs/C	0.33	0.1 M KOH	5	26
Pt(111)	0.28	0.1 M NaOH	5	31
Commercial Pt/C	0.27	0.1 M KOH	20	23
60 wt% Pd/GNS	0.25	0.1 M NaOH	10	32
Pd/C-500	0.23	0.1 M NaOH	10	30
20% Pt/C	0.21	0.1 M KOH	10	29
Ag_{0.6}Pd_{0.4}	0.20	0.1 M KOH	20	this work
Pd/C-400	0.20	0.1 M NaOH	10	30
spherical Pd NPs	0.20	0.1 M KOH	10	27
40 wt% Pt/C	0.19	0.1 M KOH	10	33
Pd@PdPt NCs	0.19	0.1 M KOH	10	29
Pt/C	0.18	0.1 M KOH	20	34
Pd/C-300	0.17	0.1 M NaOH	10	30
60 wt% Pt/GNS	0.16	0.1 M NaOH	10	32
Pd/C-AR	0.14	0.1 M NaOH	10	30
Commercial Pd/C	0.14	0.1 M KOH	20	23
Ni@Pd₃/C NPs	0.13	0.1 M KOH	20	34
PtCu₃ NPs/C	0.13	0.1 M KOH	5	26
Pt/C	0.12	0.1 M KOH	20	25
Bulk Pt disk	0.12	0.1 M KOH	10	33
Pt/TiO₂-FGS	0.11	0.1 M KOH	10	33
Ni@Pd₂ NPs/C	0.11	0.1 M KOH	20	34
Ni₃@Pd NPs/C	0.10	0.1 M KOH	20	34
Ni@Pd NPs/C	0.08	0.1 M KOH	20	34
Ag_{0.7}Pd_{0.3}	0.07	0.1 M KOH	20	this work
Pd NPs/C	0.06	0.1 M KOH	20	34
CoZn-NC 700	0.05	0.1 M KOH	5	35

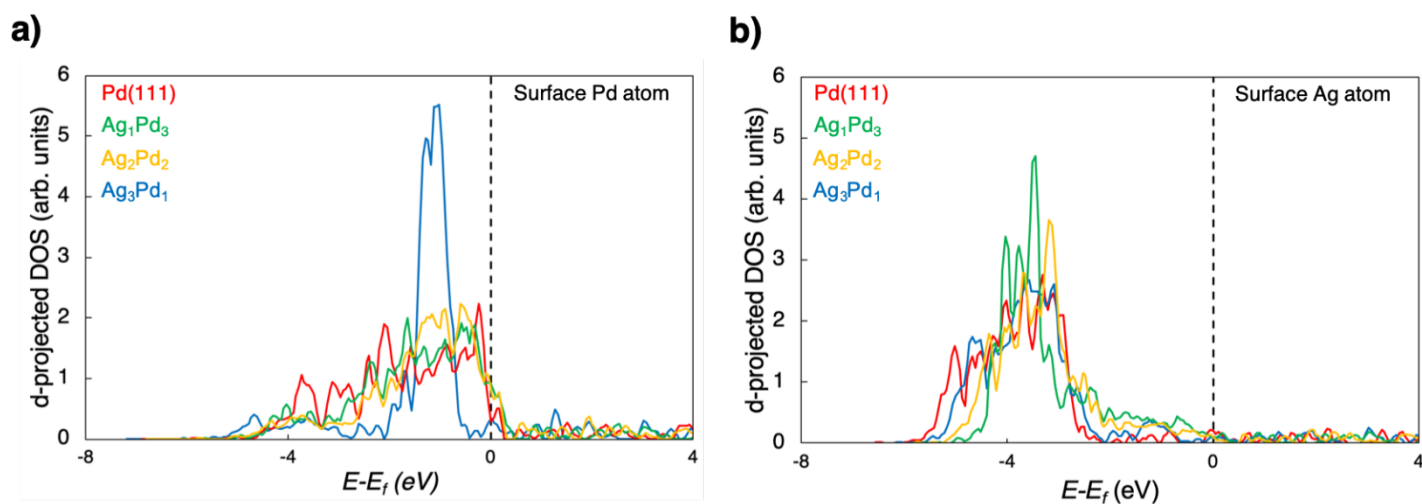
Supplementary Note 10: Density Functional Theory Modeling

To evaluate if the Ag-rich surfaces investigated in this study are susceptible to surface segregation, the segregation energies for a bulk Pd atom in a Ag(111) lattice were calculated at vacuum and in the presence of an adsorbed *OH. Segregation of a bulk Pd atom to the surface of Ag(111) was found to be unfavorable under vacuum conditions, while, in the presence of adsorbed *OH, segregation is slightly thermodynamically favorable. This indicates that the surface layer generally prefers to maximize the available Ag content under vacuum conditions, while Pd sites are stabilized on the surface in the presence of adsorbed *OH. In contrast, XPS (**Supplementary Figures 4, 14c, and 14d**) and GI-XRD (**Figure 1b** and **Supplementary Figure 1c**) data suggest that, within technique sensitivity (top several nanometers), the Ag-Pd alloy thin films did not undergo major surface rearrangements during ORR experiments.

Interestingly, the limiting potential for the ORR on Pd_{atom}-Ag (-5%) and Pd_{layer}-Ag(111) were similar to those on Pt(111) and Pd(111). These two Ag-Pd configurations (Pd_{atom}-Ag (-5%) and Pd_{layer}-Ag) could serve as a strategy to further reduce Pd loading in Ag-Pd bimetallic systems without large activity losses. Specifically, this motivates studying monodispersed Pd on a Ag matrix grown under lattice compression, and further investigating systems such as Pd@Ag core-shell nanoparticles (or layered thin films).

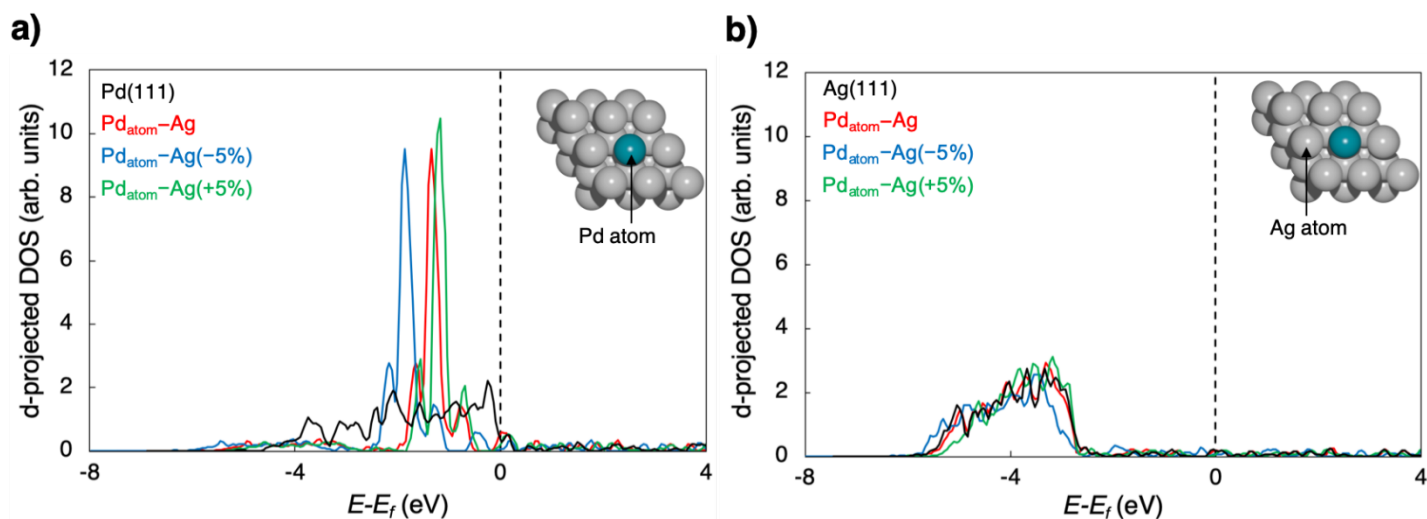


Supplementary Figure 15. Select strain effect calculations. (a) Effect of compressive and tensile strain on the calculated limiting potentials for Ag(111) surface. (b) Effect of compressive and tensile strain on the calculated limiting potentials for Pd_{atom}-Ag(111) surface. (Relevant for **Figure 3** in main text).



Supplementary Figure 16. Ag-Pd d-projected density of states. d-projected density of states (PDOS) for (a) Pd atom in Pd(111), Ag₁Pd₃(111), Ag₂Pd₂(111), and Ag₃Pd₁(111), and (b) Ag atom in Ag(111), Ag₁Pd₃(111), Ag₂Pd₂(111), and Ag₃Pd₁(111). (Relevant for **Figure 3** in main text).

Supplementary Figure 16a indicates that the *d*-projected density of states of Pd atom in Pd(111), Ag₁Pd₃(111), and Ag₂Pd₂(111) are similar while Ag₃Pd₁(111) is significantly different. The *d*-projected density of states of Pd atom in Ag₃Pd₁(111) resembles the sharp peak observed on Pd atom in Pd_{atom}-Ag(111) surface (Figure S10.3) though a slight broadening and decrease in intensity is observed. This broadening could be attributed to the compensating effects of compressive strain in Ag₃Pd₁(111) compared to Pd_{atom}-Ag(111). A slightly lower *d*-band edge relative to the Fermi level is observed for Ag₁Pd₃(111) and Ag₂Pd₂(111) indicating a weaker oxygen adsorption on Pd atom which resulted in increase in activity (**Figure 3b**). On the other hand, **Figure 1b** shows rather similar *d*-projected density of states of Ag atom in Ag(111) and Ag₃Pd₁(111) surfaces while the Ag atom in Ag₁Pd₃(111) and Ag₂Pd₂(111) shows a slight narrowing of the *d*-band and slightly lower *d*-band edge relative to the Fermi level.



Supplementary Figure 17. Pd_{atom}-Ag(111) *d*-projected density of states. *d*-projected density of states (PDOS) for (a) Pd atom in Pd(111) and Pd_{atom}-Ag(111) surface with 5%, 0%, -5% strain. (b) Ag atom in Ag(111) and Pd_{atom}-Ag(111) surface with 5%, 0%, -5% strain. (Relevant for **Figure 3** in main text).

Supplementary Figure 17a indicates that the *d*-projected density of states of Pd atom in Pd_{atom}-Ag(111) surface is significantly different from a Pd atom in Pd(111) surface and a formation of a sharp peak near the Fermi level.

This peak could result from the ineffective mixing of the electron densities of the Pd single atom and the Ag(111) surface and the effective tensile strain on the Pd single atom due to large lattice of Ag(111). A lower *d*-band edge relative to the Fermi level is observed for Pd single atom in -5% compressively strained Ag(111), Pd_{atom}-Ag(-5%), compared to Pd_{atom}-Ag and Pd_{atom}-Ag(5%) indicating a weaker oxygen adsorption on Pd atom. This results in increase in ORR overpotential and therefore increased activity. A similar *d*-projected density of states of Ag atom in Ag(111) and Pd_{atom}-Ag(111) surfaces with different strains is observed (**Supplementary Figure 17b**) indicating that the ORR activity of these Ag atoms are not affected.

Supplementary Table 5. DFT adsorption free energies of OH* and OOH*, and thermodynamic limiting potentials and steps for considered Ag-Pd active site models in **Figure 3a**. Note that all the considered surfaces are (111) facets. (This is the data plotted on **Figure 3b** in the main text).

Active site model	ΔG_{OH^*} (eV)	ΔG_{OOH^*} (eV)	U_L (V)	Potential limiting step
Pt³⁶	0.80	4.00	0.80	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Pd	0.79	4.12	0.79	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Ag	1.10	4.31	0.61	O ₂ + (H ⁺ +e ⁻) + * → OOH*
Ag(+5%)	0.94	4.19	0.73	O ₂ + (H ⁺ +e ⁻) + * → OOH*
Ag(-5%)	1.17	4.45	0.47	O ₂ + (H ⁺ +e ⁻) + * → OOH*
Pd_{atom}-Ag	0.63	3.99	0.63	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Pd_{atom}-Ag(+5%)	0.37	3.65	0.37	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Pd_{atom}-Ag(-3%)	0.72	4.04	0.72	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Pd_{atom}-Ag(-5%)	0.80	4.12	0.80	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Pd_{layer}-Ag	0.83	4.14	0.78	O ₂ + (H ⁺ +e ⁻) + * → OOH*
Ag_{layer}-Pd	1.19	4.47	0.45	O ₂ + (H ⁺ +e ⁻) + * → OOH*
Ag₃Pd₁	0.72	3.99	0.72	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Ag₂Pd₂	0.82	4.09	0.82	OH* + (H ⁺ +e ⁻) → H ₂ O + *
Ag₁Pd₃	0.83	4.07	0.83	OH* + (H ⁺ +e ⁻) → H ₂ O + *

Supplementary Table 6. Effective Bader charges (q) defined as $q = Z_{val} - q_{Bader}$, where Z_{val} is the number of valence electrons determined by POTCAR file (pseudopotential for each atomic species) in VASP and q_{Bader} is the computed Bader charge for few considered Ag–Pd active site models in **Figure 3a**. Note that all the considered surfaces are (111) facets.

Active site model	Effective Bader charge (e)	
	Ag atom	Pd atom
Pd	–	–0.02
Ag	–0.02	–
Ag(+5%)	–0.03	–
Ag(–5%)	–0.01	–
Pd_{atom}–Ag	0.00	–0.23
Ag₃Pd₁	0.04	–0.22
Ag₂Pd₂	0.10	–0.15
Ag₁Pd₃	0.13	–0.08

DFT Methodology Notes. All the DFT calculations performed in this study are spin polarized. Specifically, we use the `ISPIN = 2` tag to turn on the spin and then define the magnetic moment using the `MAGMOM` tag as implemented in VASP. Because no drastic change in observed activity trends is expected due to valence spin orbits, in this study we do not consider valence spin orbits.³⁷ We do not account for dispersion interactions because they are expected to only have a minor effect and generally calculations for chemisorbed species using RPBE and BEEF–vdW (which accounts for dispersion interactions) follow similar trends.³⁸ While adsorbate–adsorbate interactions could play a role in the apparent catalyst activity, we anticipate similar adsorbate–adsorbate interactions across all the metal surfaces considered in this study due to the similarity in surface atoms ordering (all considered surfaces are (111) facets) and hence similarity in the resulting adsorbate–adsorbate distances. Therefore, adsorbate–adsorbate interactions would likely not change the calculated activity trends. The aim of this work is to look at activity trends across the Ag–Pd compositional spectrum and therefore a detailed analysis considering adsorbate–adsorbate interactions for all the individual surfaces is beyond the scope of this study.

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